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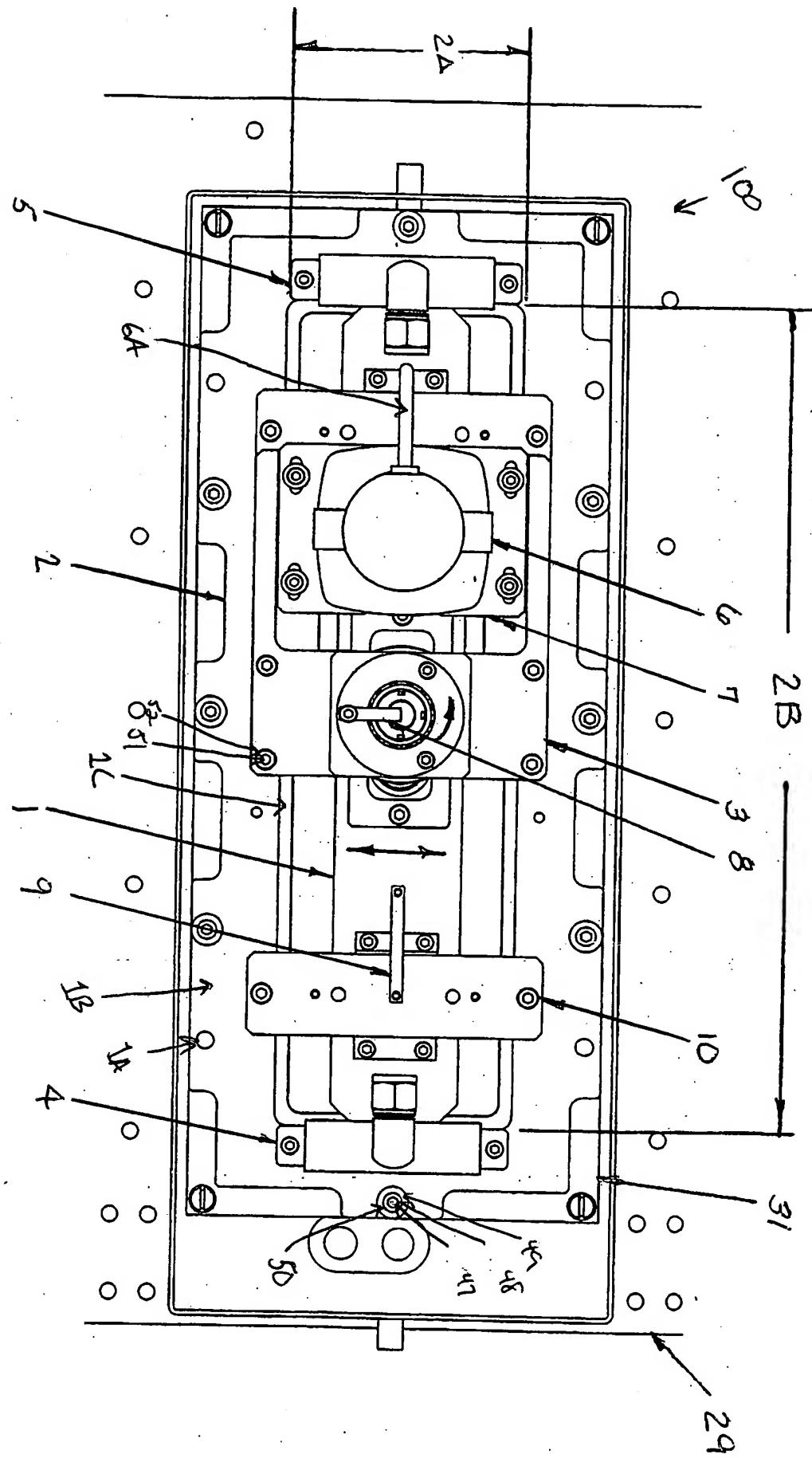
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FIG 1
TOP VIEW



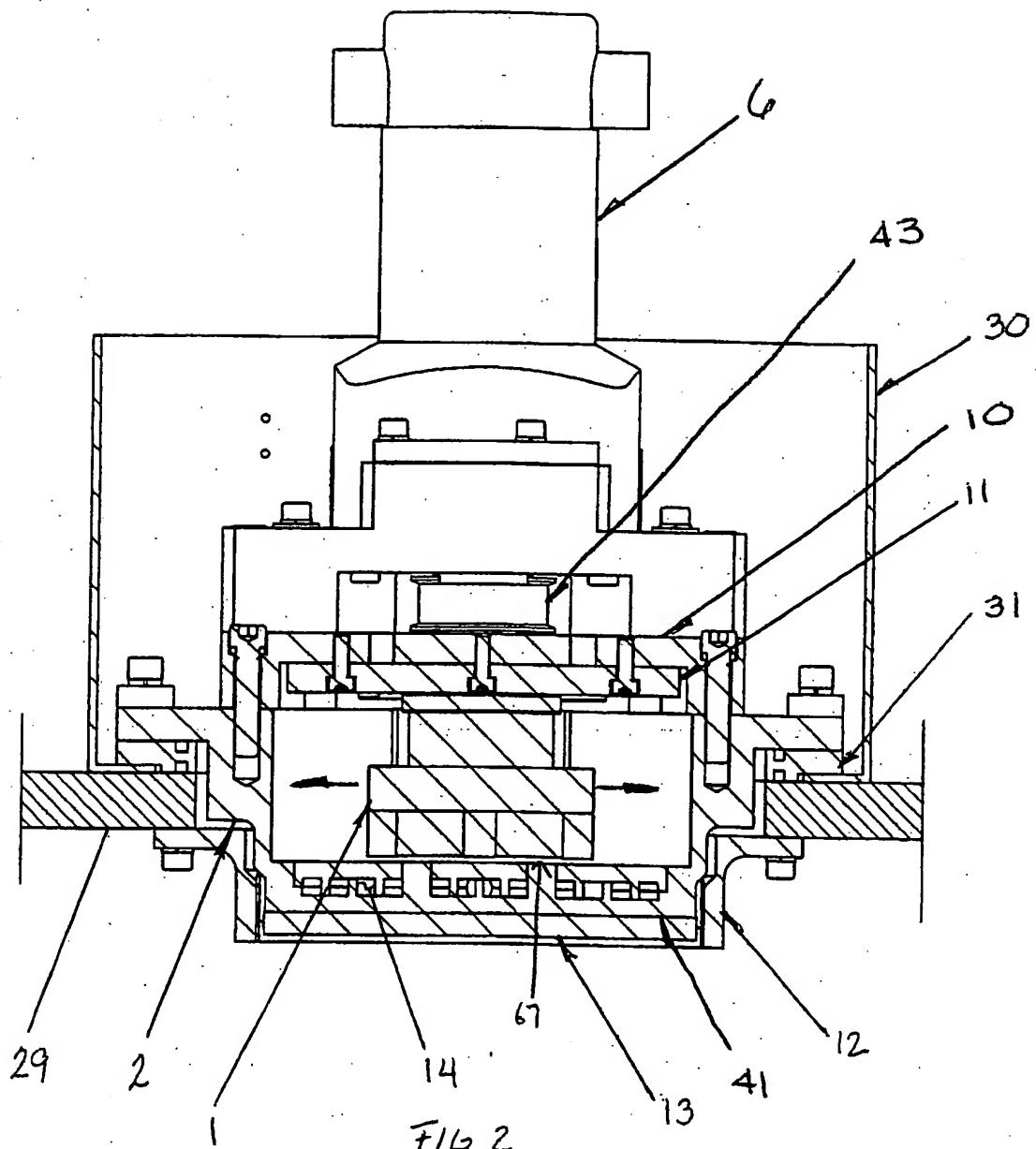
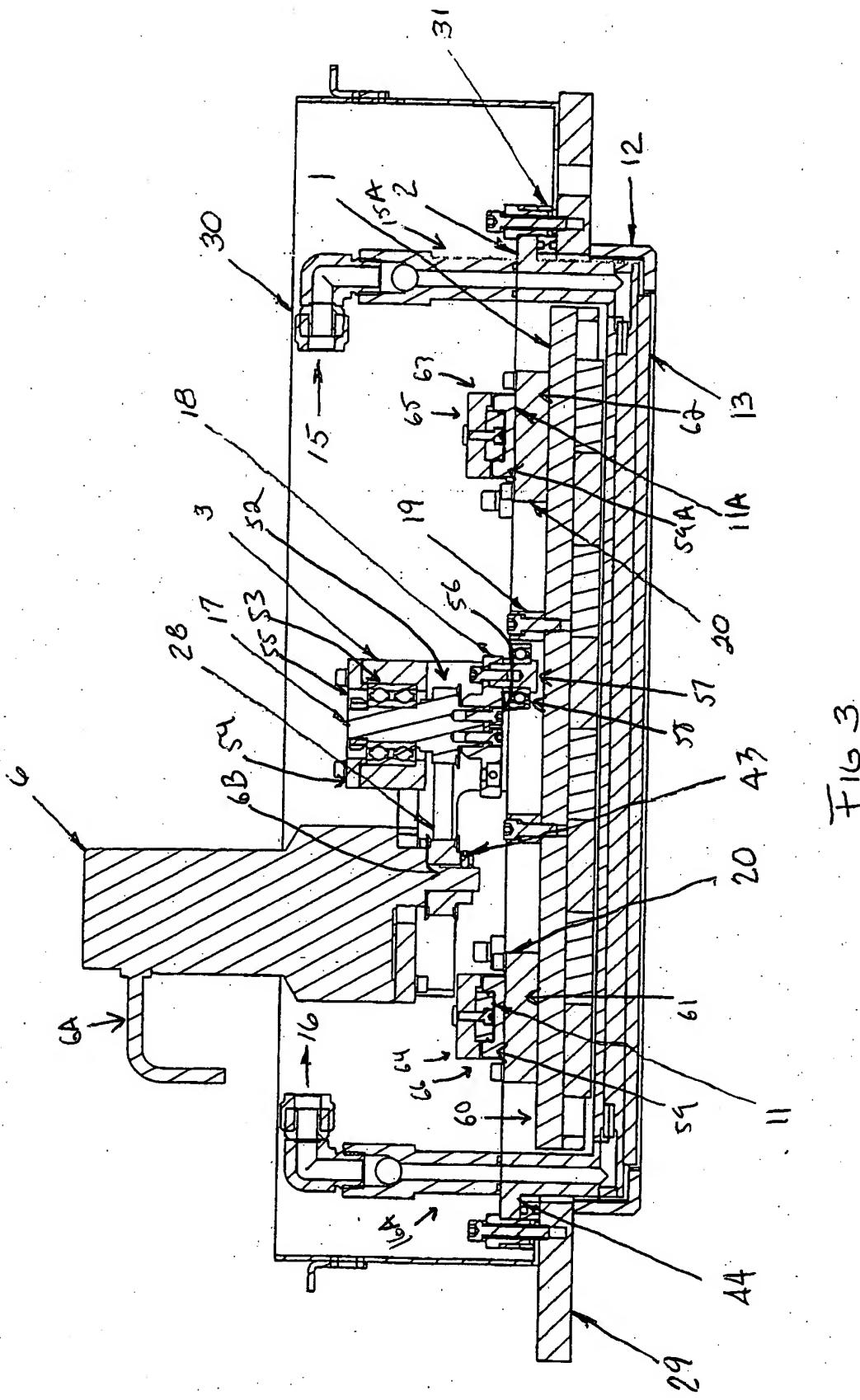
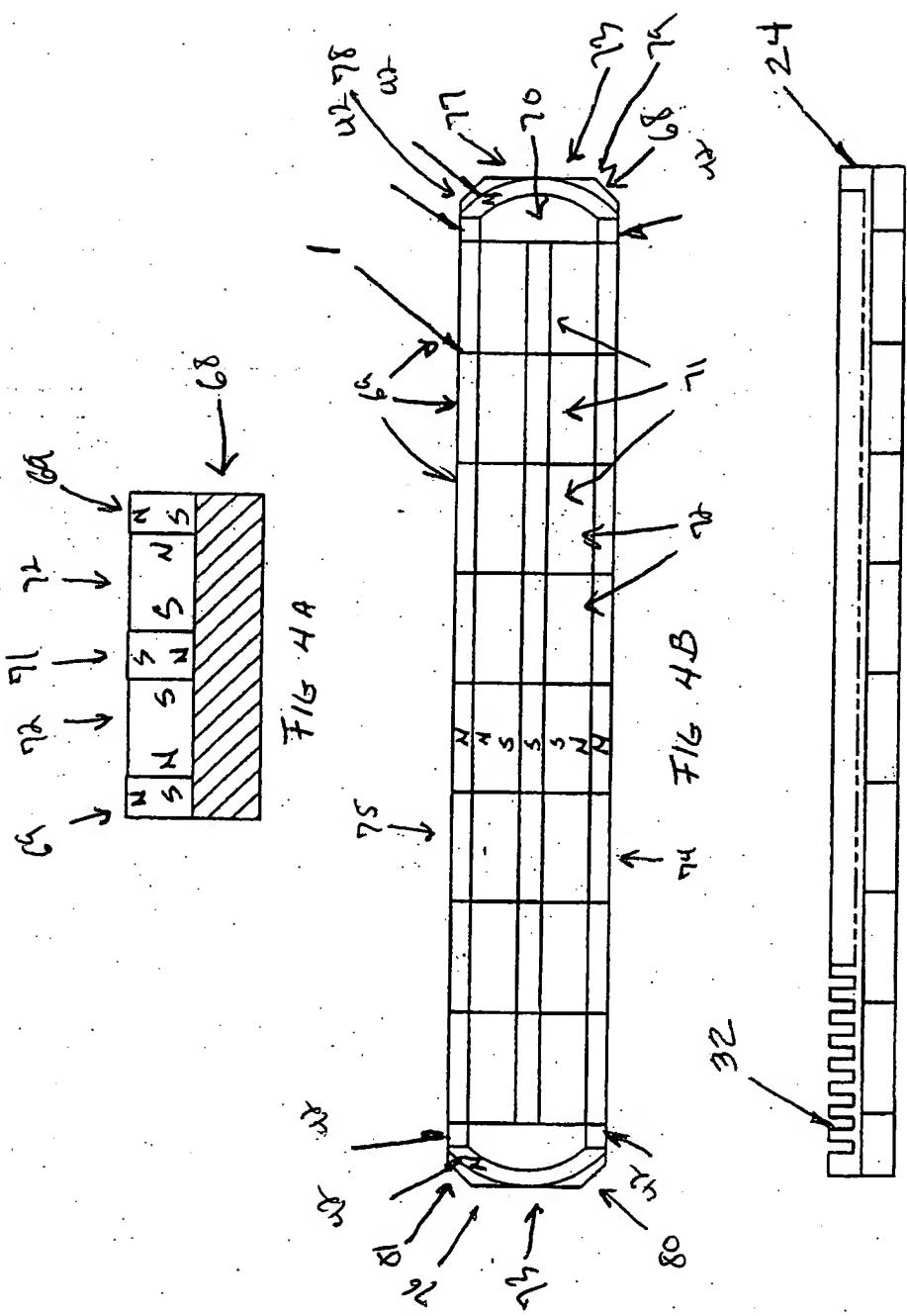


FIG 2

EUD View





Comparative Field Strength Along Center of Erosion

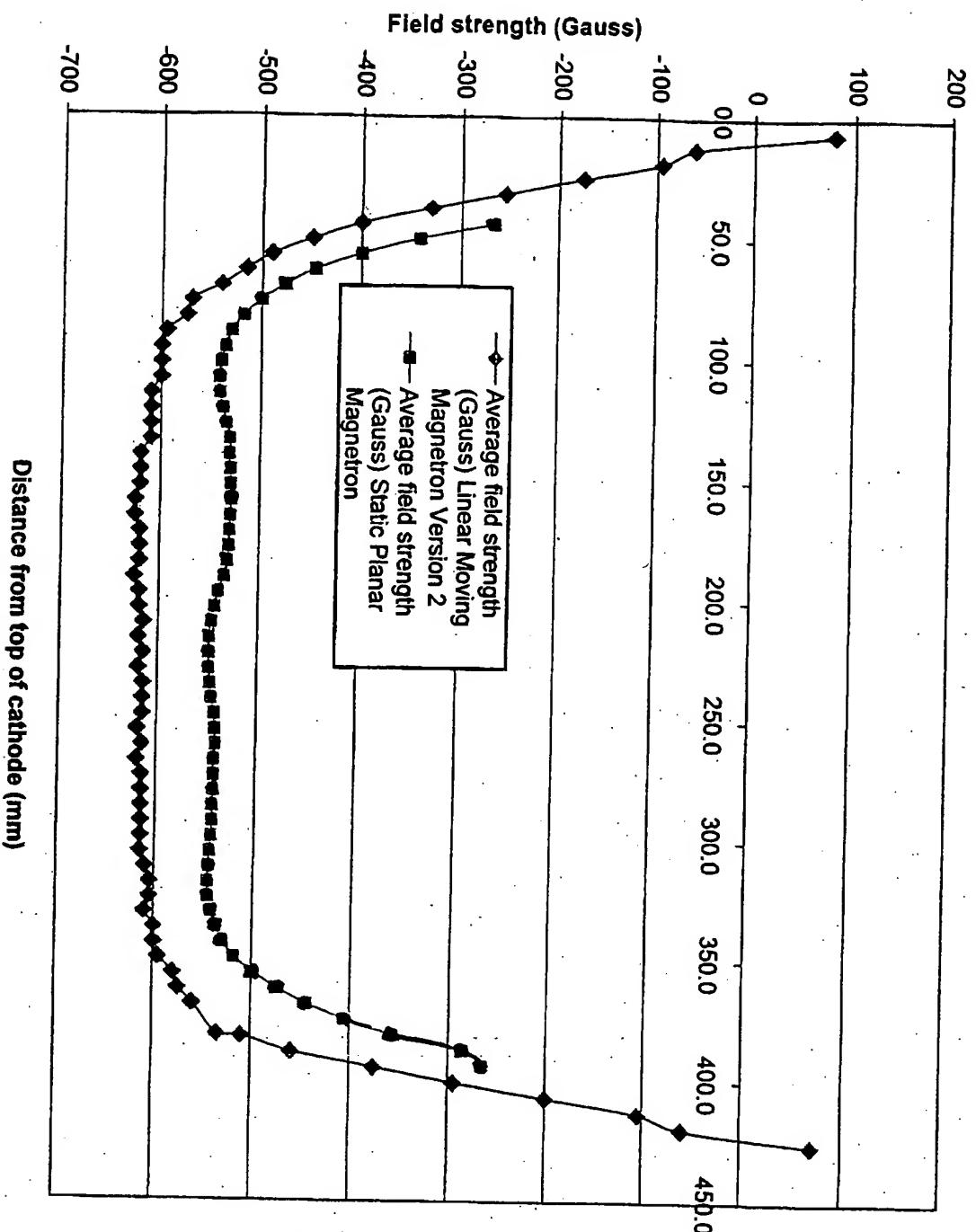


Figure 5.

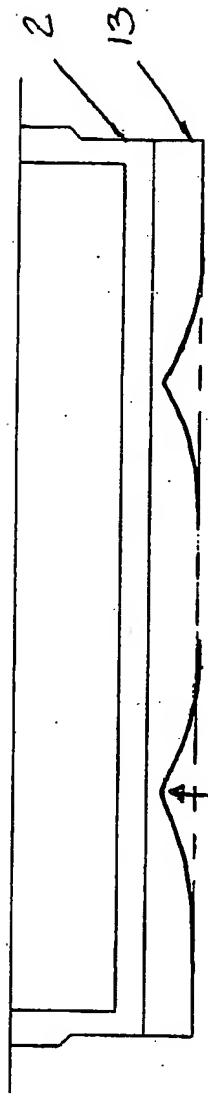


Fig 6A
Previous Art

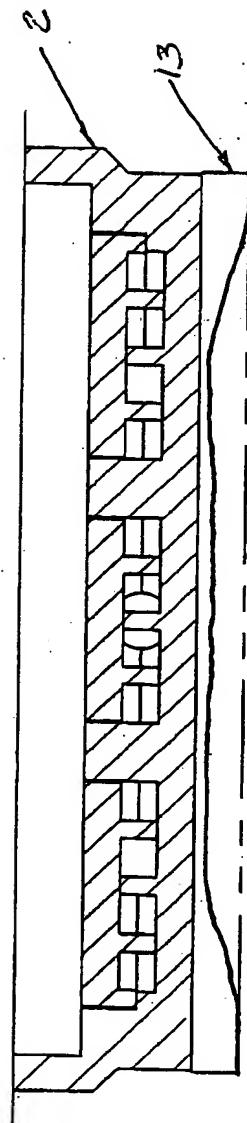
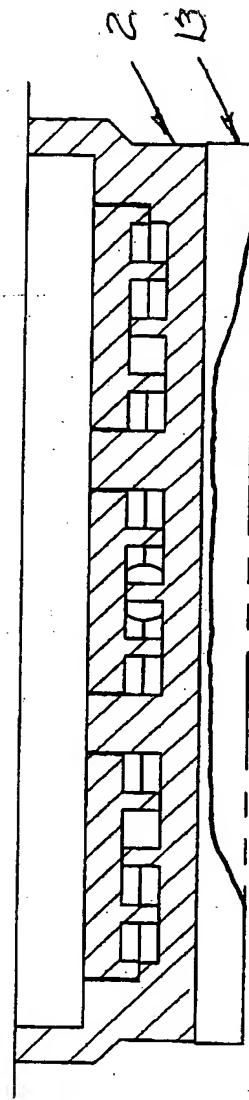
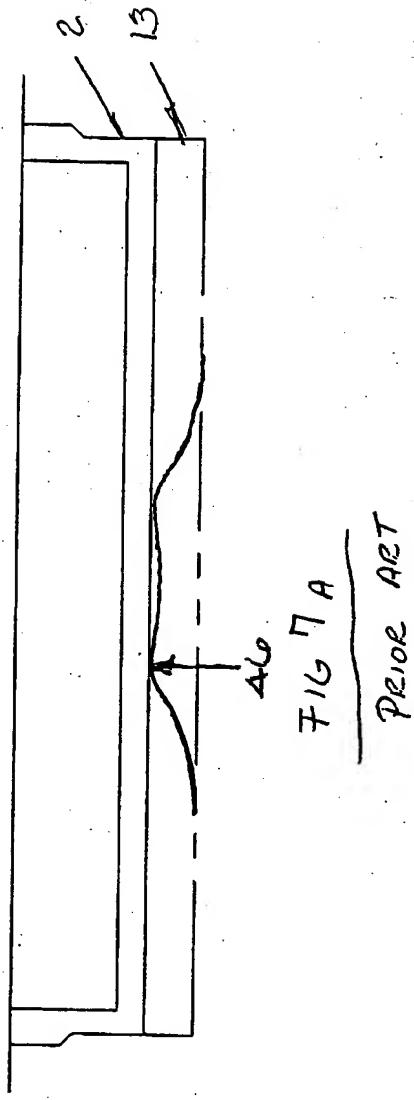
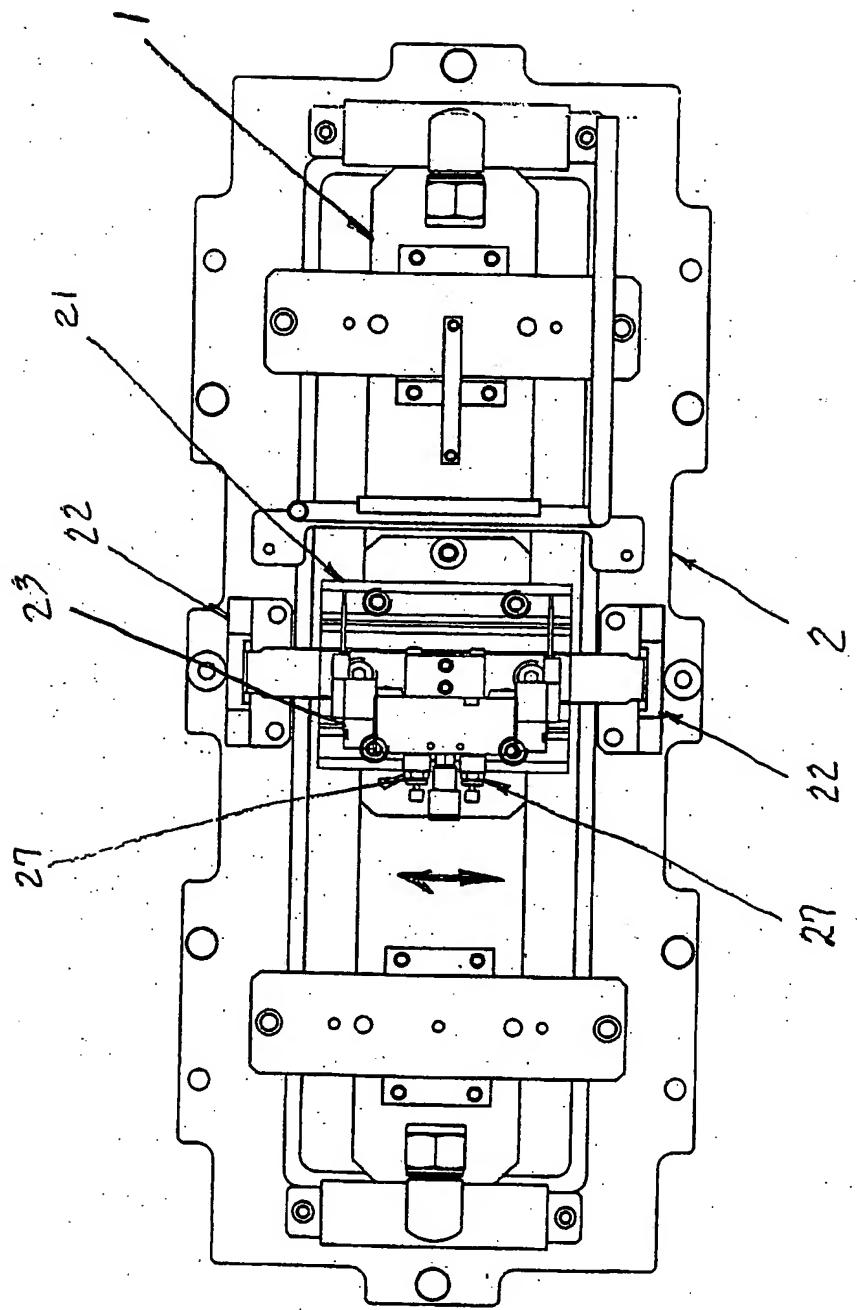
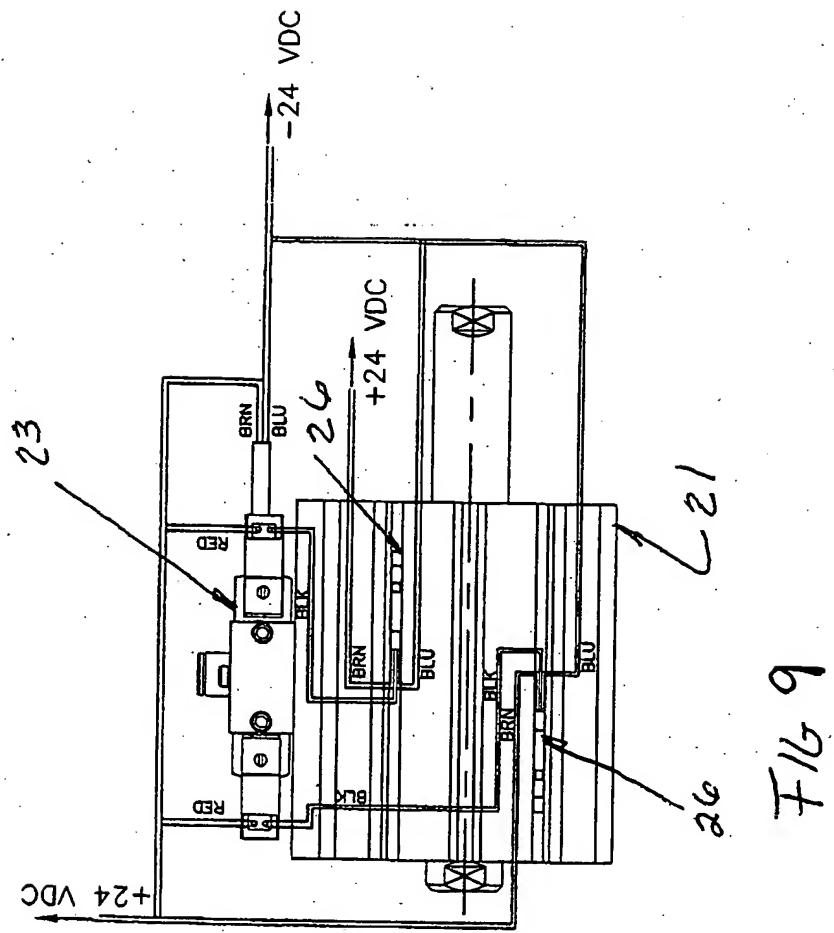


Fig 6B





F16 8



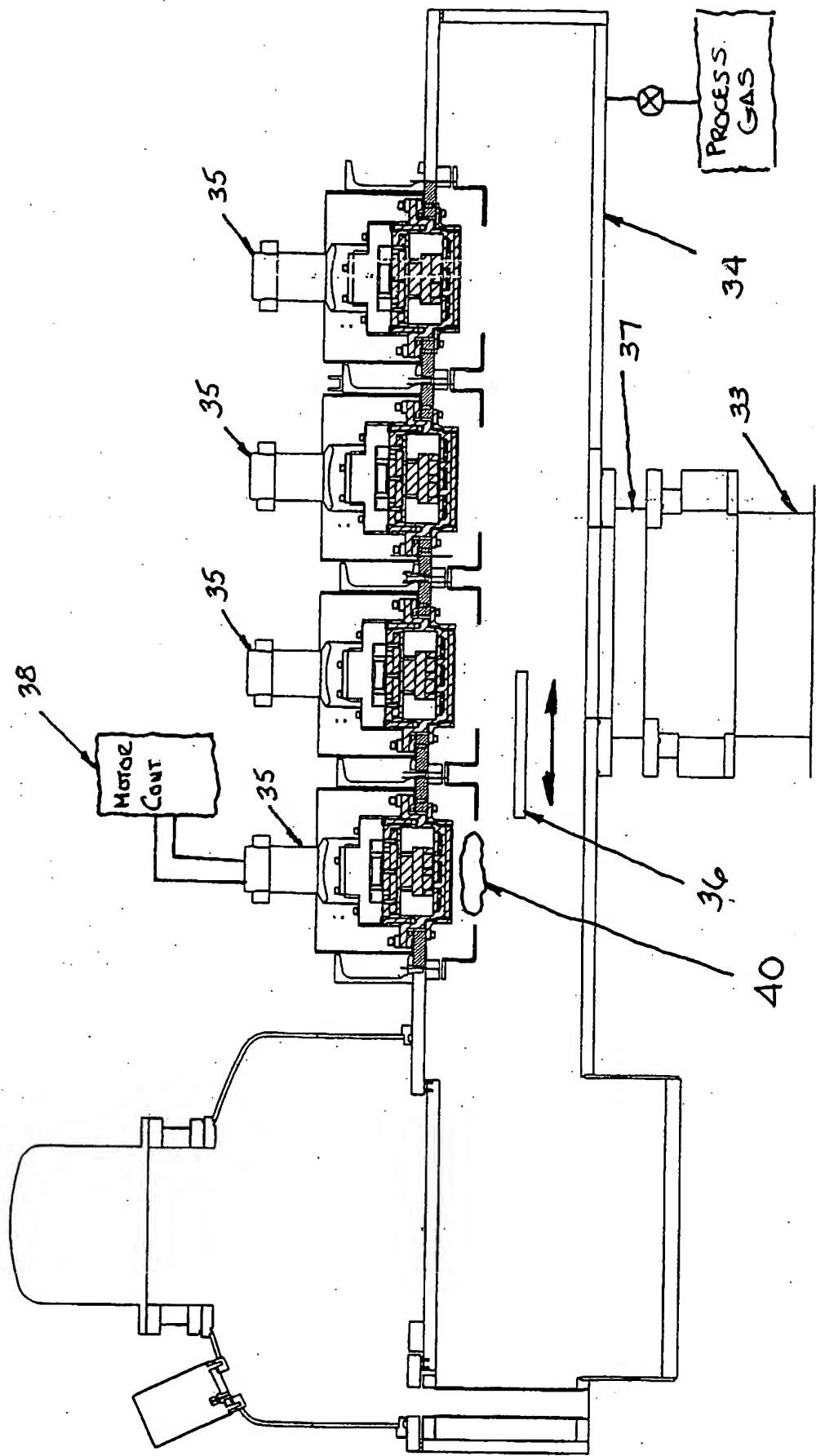


Fig 10

**Aluminum thickness profile top-to-bottom
LMM cathode version 3**

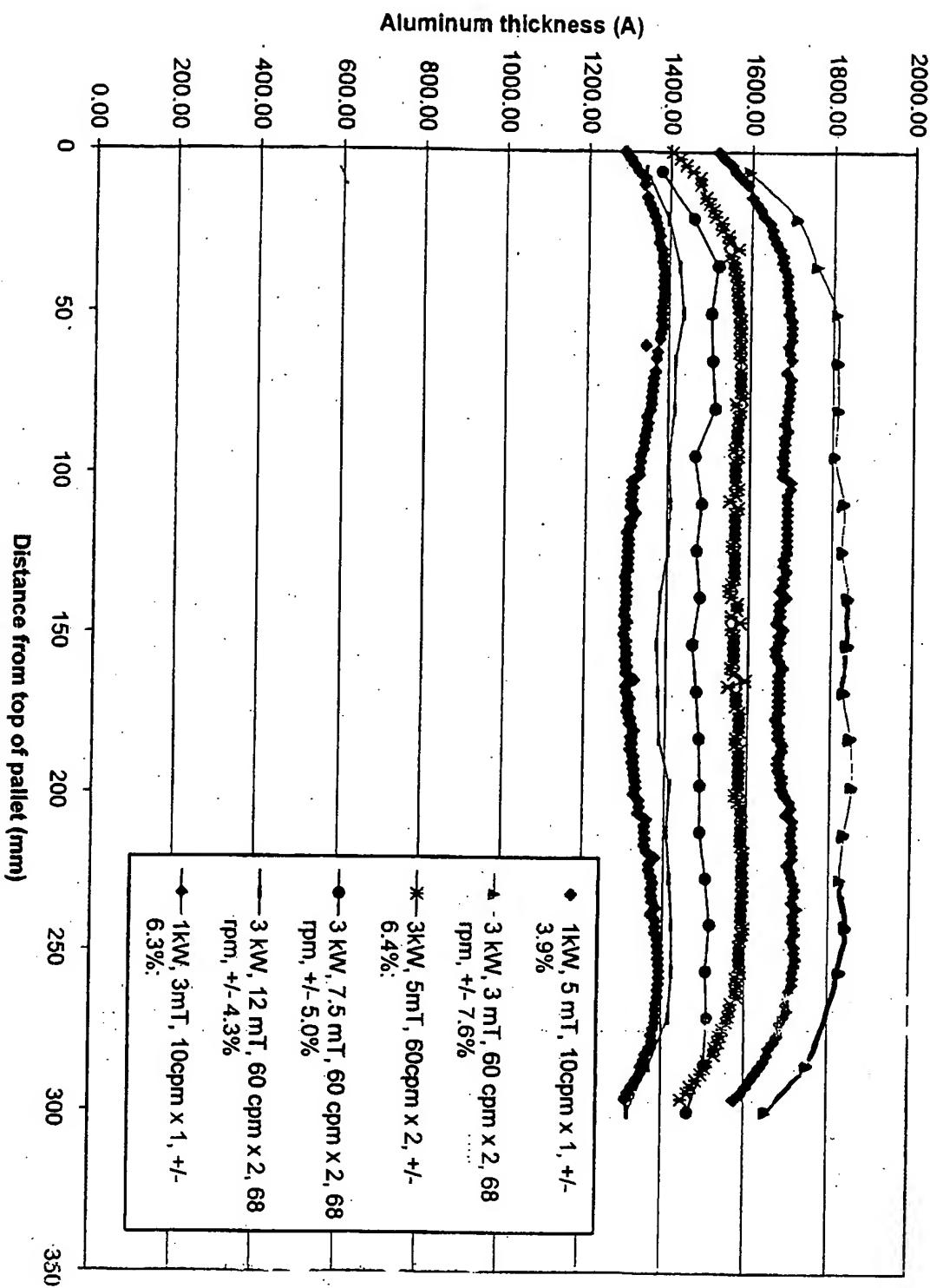


FIGURE 11.

**Aluminum oxide thickness profile top-to-bottom
LMM cathode version 3**

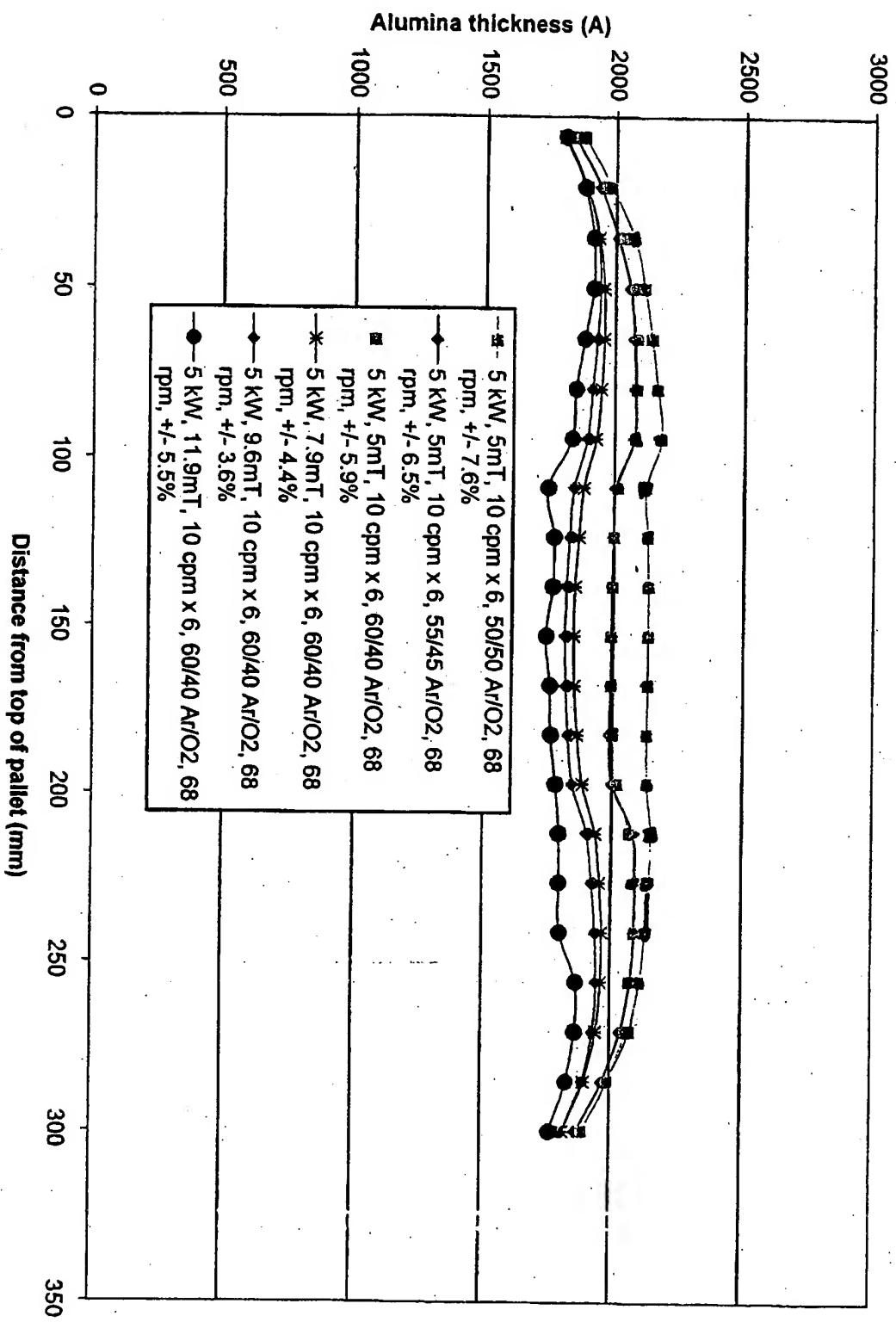


FIGURE 12.

Aluminum Oxide Hysteresis Loop for LMM Cathode

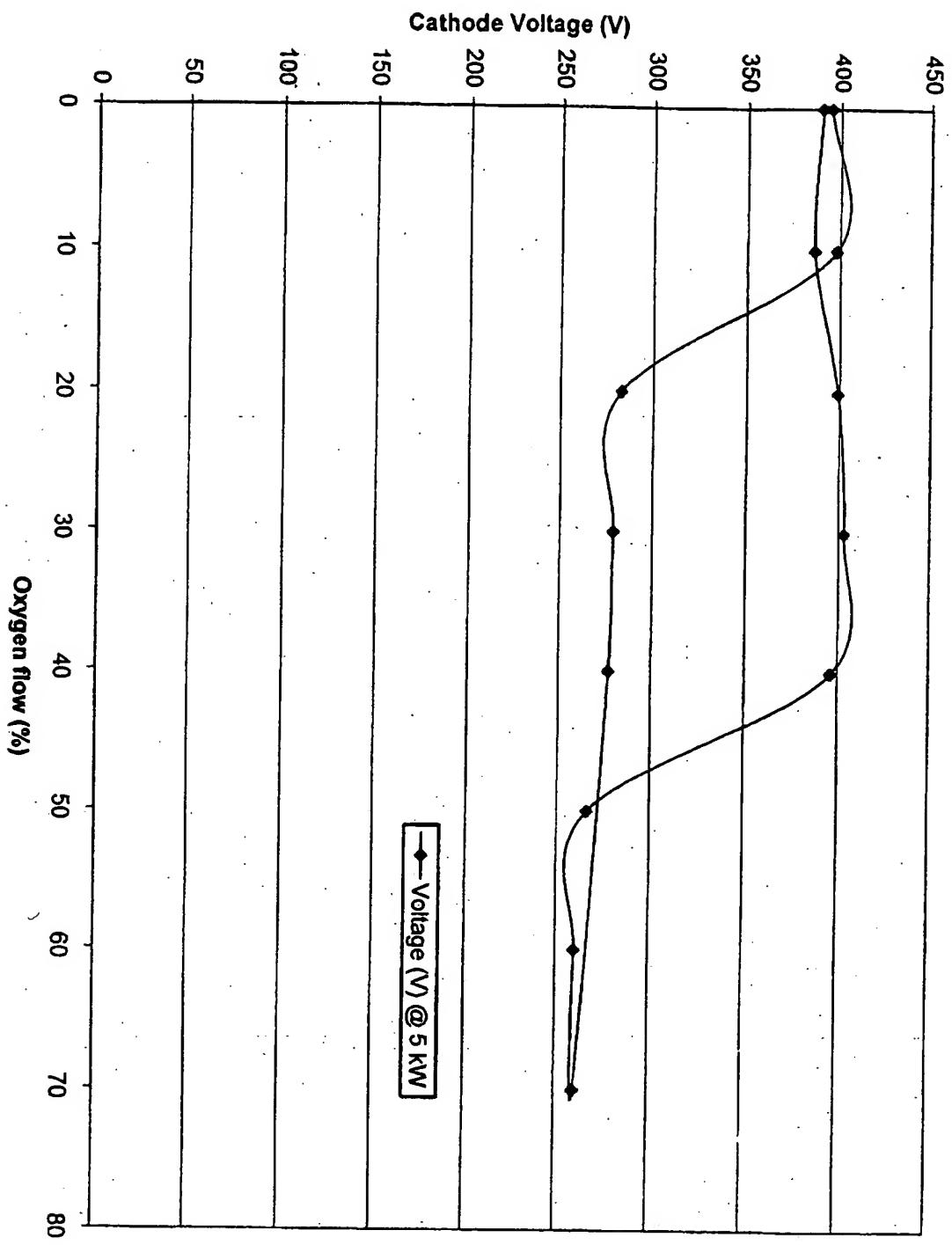


FIGURE 13.

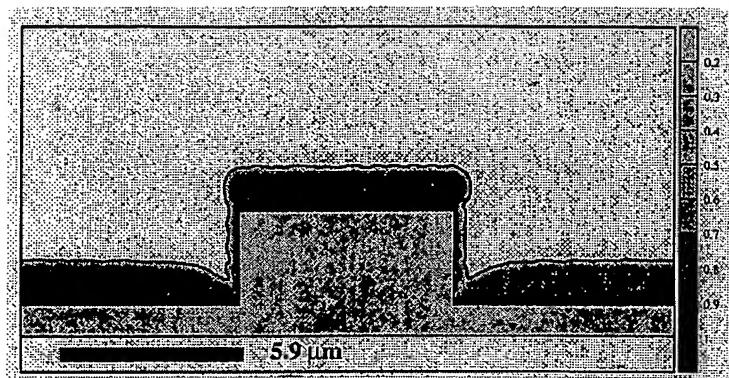


Figure 14 a. Theoretical simulation of oxide film step coverage achieved by prior art.

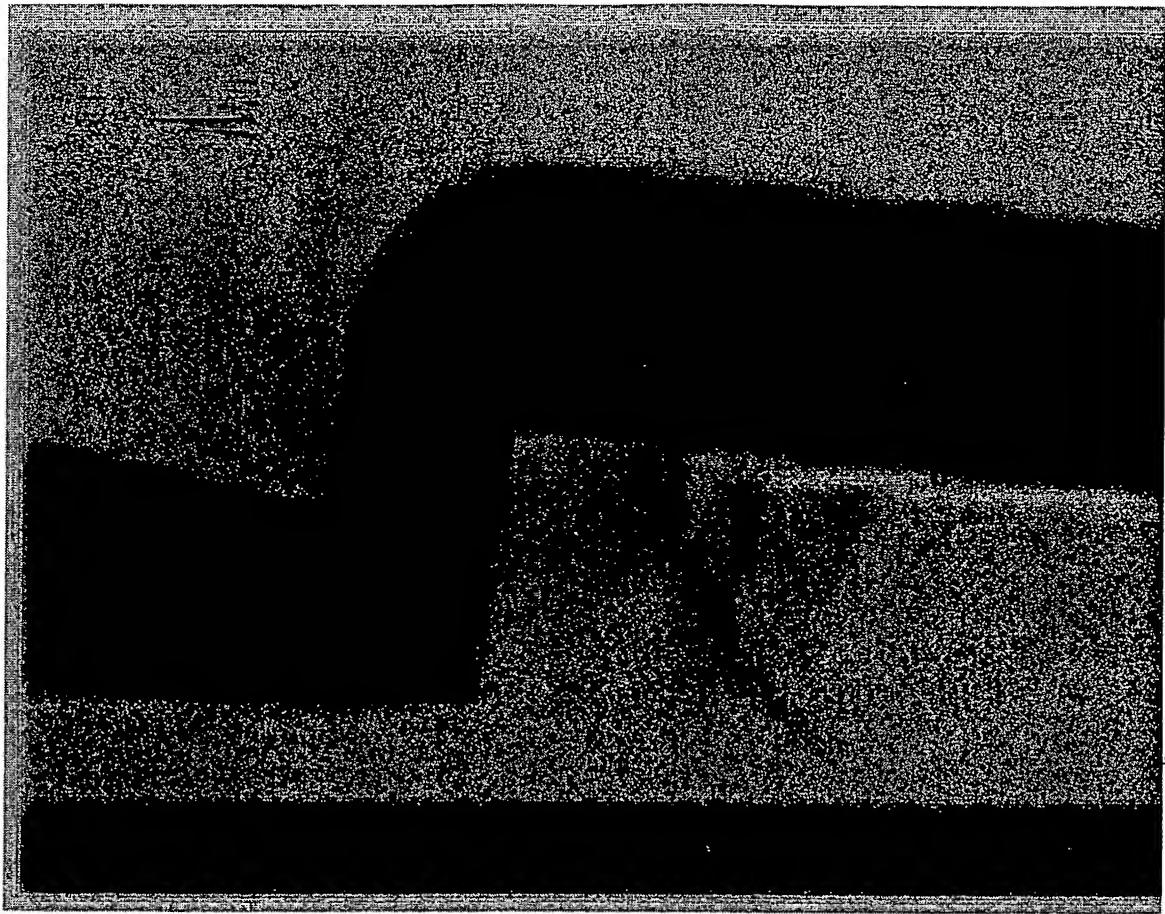


Figure 14b